Editors' Suggestion

Discovery of highly polarizable semiconductors BaZrS₃ and Ba₃Zr₂S₇

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There are few known semiconductors exhibiting both strong optical response and large dielectric polarizability. Inorganic materials with large dielectric polarizability tend to be wide-band gap complex oxides. Semiconductors with a strong photoresponse to visible and infrared light tend to be weakly polarizable. Interesting exceptions to these trends are halide perovskites and phase-change chalcogenides. Here we introduce complex chalcogenides in the Ba-Zr-S system in perovskite and Ruddlesden-Popper structures as a family of highly polarizable semiconductors. We report the results of impedance spectroscopy on single crystals that establish BaZrS₃ and Ba₃Zr₂S₇ as semiconductors with a low-frequency relative dielectric constant ε_0 in the range 50–100 and band gap in the range 1.3–1.8 eV. Our electronic structure calculations indicate that the enhanced dielectric response in perovskite BaZrS₃ versus Ruddlesden-Popper Ba₃Zr₂S₇ is primarily due to enhanced IR mode-effective charges and variations in phonon frequencies along $\langle 001 \rangle$; differences in the Born effective charges and the lattice stiffness are of secondary importance. This combination of covalent bonding in crystal structures more common to complex oxides, but comprising sulfur, results in a sizable Fröhlich coupling constant, which suggests that charge carriers are large polarons.

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Dielectric response controls the fundamental optoelectronic properties and the functional usefulness of semiconductors. The low-frequency dielectric response controls band bending and charge transport at semiconductor junctions and the high-frequency response controls light-matter interaction. Dielectric response is also responsible for screening fixed and mobile charges, leading to polaron effects and controlling the interaction between charge carriers and lattice defects. In a recent article we highlighted the relative dearth of semiconductors that combine the band gap in the visible (VIS) and near-infrared (NIR), the essential range for much device technology, with a strong dielectric response [1]. We predicted that little-studied complex-structured chalcogenide materials may occupy this sparse region of the otherwise-well-populated Ashby plot of dielectric constant vs band gap.

Here we report experimental measurements and theoretical calculations of the dielectric response of two complex-structured chalcogenide semiconductors, $BaZrS_3$ in the perovskite structure and $Ba_3Zr_2S_7$ in the Ruddlesden-Popper structure. We find that both are highly polarizable, with low-frequency relative dielectric constant $\varepsilon_{r,0}$ in the range of 50–100. Our results are consistent with expectations that semiconductors in the perovskite and related crystal structures are highly polarizable, and they frame a hypothesis that polaron transport effects will be strong in chalcogenide

perovskites. The strong low-frequency dielectric response is intriguing in light of the long radiative lifetime previously reported in Ba₃Zr₂S₇ [2].

BaZrS₃ is isostructural with GdFeO₃ in the distortedperovskite structure, in space group Pnma [3]. It has a direct band gap of $E_g = 1.83$ eV and strong optical absorption above the band gap [3,4]. Ba₃Zr₂S₇ forms in a two-layer Ruddlesden-Popper (RP) structure, in space group P4₂/mnm [2]. It has an indirect band gap at 1.25 eV and a direct transition at 1.35 eV that results in strong optical absorption [2]. Both structures feature corner-sharing ZrS₆ octahedra, and the Zr-S-Zr bond geometry and covalence control the low-energy (i.e. near-band-edge) electronic structure [5]. Both structures are nonpolar and BaZrS₃ has antipolar cation displacements, illustrated in Fig. 1. Ba₃Zr₂S₇ is theoretically predicted to be close in energy to a polar ferroelectric phase with space group Cmc2₁ [6]. The dielectric properties of chalcogenides in the perovskite and RP structures have not been reported beyond an early theoretical prediction of $\varepsilon_{r,0} = 46$ for BaZrS₃ [7].

We performed impedance spectroscopy measurements on single-crystal samples that we grew using the salt flux growth technique, as reported previously [8]. We embedded the crystals in acrylic epoxy (SamplKwick, Buehler) to assist with sample handling and contacting. We ground and polished the epoxy handle to expose two opposite crystal faces. We formed parallel-plate capacitors by bonding Pt wire with a diameter of 0.001 in. to the two opposite crystal faces, using conductive silver epoxy (LCA-24, Bacon Adhesives). For

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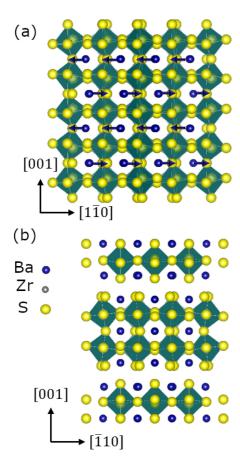


FIG. 1. Crystal structures of (a) $BaZrS_3$ and (b) $Ba_3Zr_2S_7$. The blue, gray, and yellow spheres represent Ba, Zr, and S, respectively. ZrS_6 octahedra are shaded in green. The blue arrows indicate the antipolar pattern of Ba^{2+} cation displacements in $BaZrS_3$.

some samples, we deposited 60 nm of Au by sputtering on the crystal faces before contacting the Pt wire. We made accurate measurements of the capacitor dimensions using micro x-ray computed tomography (μ CT) (X-Tek), as shown in Figs. 2(a) and 2(b).

The small sample size presented a challenge to accurate impedance measurements. The typical crystal dimensions are $100 \times 100 \times 100 \, \mu \text{m}^3$ and the typical capacitance is in the range of 0.1--1 pF, making it essential to remove stray capacitance from the measurement circuit. To do so, we made custom test fixtures that maintain shielding to within ≈ 5 mm of the wired sample [Fig. 2(c)]. With these custom fixtures, the stray capacitance of our measurement circuit without a sample was below the detection limit of our impedance analyzer. We performed temperature-dependent measurements between 2 and 300 K using a helium cryostat (PPMS DynaCool, Quantum Design) equipped with a coaxial-cabling insert.

For temperature-dependent measurements we used an impedance analyzer (Hewlett Packard 4192A) in parallel *R-C* mode, 1 V AC drive, with zero adjustment over a frequency range from 1 kHz to 1 MHz. We also performed impedance spectroscopy measurements in ambient conditions over a wider frequency range, from 0.1 Hz to 1 MHz, using a separate impedance analyzer (Novocontrol Alpha-A, with a potentiostat/galvanostat 30V-2A test interface). Our low-frequency

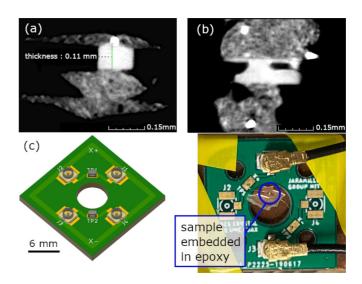


FIG. 2. Illustration of techniques used to enable accurate impedance measurements on microscopic crystals. (a) and (b) μ CT cross-section images used to determine the sample dimensions. Images show crystals and Ag epoxy contacts. Pt wires used for electrical leads appear as small bright spots. (a) A BaZrS₃ crystal with the thickness determined to be 0.11 mm. (b) A BaZrS₃ crystal for which μ CT revealed a macroscopic void beneath the crystal surface; this sample was subsequently not used for impedance measurements. (c) Drawing and photograph of the custom test fixture used to enable measurements of subpicofarad sample capacitance. The surface mounts are ultraminiature coaxial connectors. The photograph shows a sample mounted in epoxy and wired to the fixture (upper left and lower right contact pads).

measurements in ambient conditions suffered from a slow drift in sample resistance, possibly due to conduction through adsorbed water on the surface of the highly resistive samples. To circumvent this problem, we used a shunt resistor to draw current at low frequency. This intervention made it possible to fit the Nyquist plots, and the sample impedance determined in this way is consistent with that measured directly at high frequency.

We performed density functional theory (DFT) calculations using the Vienna Ab initio Simulation Package with projector-augmented wave pseudopotentials and the revised Perdew-Burke-Ernzerhof generalized gradient approximation functional that improves equilibrium properties of densely packed solids and their surfaces (PBEsol) [9–11]. The valence electronic configurations for the pseudopotentials are as follows: $5s^25p^46s^2$ for Ba, $4s^24p^65s^24d^2$ for Zr, and $3s^23p^4$ for S. We employed a cutoff energy of 600 eV for both BaZrS₃ and Ba₃Zr₂S₇, as well as Γ-centered k-point meshes of $6\times6\times4$ (BaZrS₃) and $6\times6\times2$ (Ba₃Zr₂S₇). The electronic convergence threshold was 1×10^{-8} eV and the ionic force threshold was 1×10^{-5} eV/Å for both structures. After relaxation, the stress tensor components for both structures were less than 8.6×10^{-4} kbar. A Gaussian smearing with a 0.1 eV smearing width was also used for both structures. Dielectric properties were computed using density functional perturbation theory.

For BaZrS₃ we find experimentally that $\varepsilon_{r,0} = 80 \pm 14$, representing seven unique samples and eleven independent

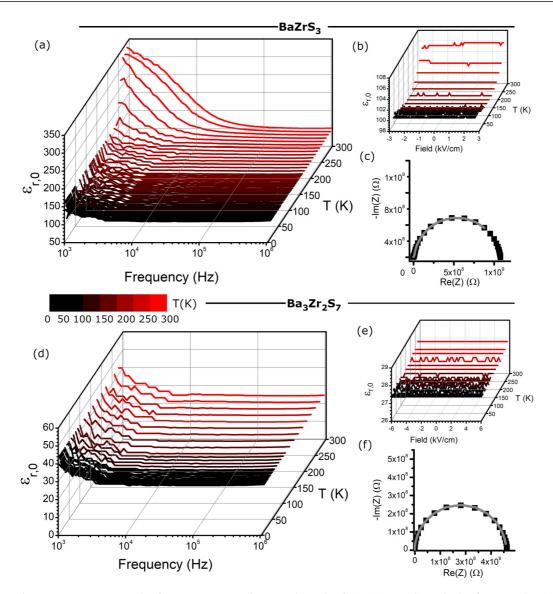


FIG. 3. Impedance measurement results for one representative sample each of (a)–(c) BaZrS $_3$ and (d)–(f) Ba $_3Z$ r $_2S$ 7. (a) and (d) $\varepsilon_{r,0}$ measured for frequency between 1 kHz and 1 MHz and temperature between 2 and 300 K. (b) and (e) Dependence of $\varepsilon_{r,0}$ on an applied electric field. (c) and (f) Nyquist plot of complex impedance (Z'-iZ'') measured between 0.1 Hz and 1 MHz ambient conditions; points are the data and the line is the fit.

measurements. For Ba₃Zr₂S₇ we find $\varepsilon_{r,0} = 72 \pm 37$, representing five unique samples and nine independent measurements. In Fig. 3 we present detailed impedance analysis results for one representative sample each of BaZrS₃ and Ba₃Zr₂S₇. In Figs. 3(a) and 3(d) we present the real component of the complex relative dielectric permittivity ε_r over the frequency range from 1 kHz to 1 MHz between 2 and 300 K. The response for both samples is nearly constant with frequency and temperature, except for a rise at low frequency and high temperature, which is more pronounced for BaZrS₃. We take the response above 10^5 Hz to be representative of the static dielectric constant.

In Figs. 3(b) and 3(e) we present the dependence of the dielectric response on a static electric field, which is added to the 1 V AC drive, measured at 100 kHz. We find no change in permittivity for electric field strengths up to 2.7 and 6 kV/cm for $BaZrS_3$ and $Ba_3Zr_2S_7$, respectively, at any

temperature between 2 and 300 K. Ba $_3$ Zr $_2$ S $_7$ is paraelectric, but it is close in energy to a ferroelectric phase [6]. Therefore, it may be expected to exhibit field-driven nonlinear capacitance, such as is observed in SrTiO $_3$ for field strength greater than 2 kV/cm at low temperature [12–14]. The crystals measured here are oriented with the electric field along the $\langle 001 \rangle$ crystal axis. We suggest that measurements with electric field applied along the $\langle 110 \rangle$ predicted polar distortion axis may reveal field-induced nonlinearity and phase transitions.

In Figs. 3(c) and 3(f) we show representative Nyquist plots of the impedance data measured between 0.1 Hz and 1 MHz, as described above, together with fits using an *R*-CPE parallel circuit model. The results for sample impedance obtained from the Nyquist analysis are in good agreement with those obtained by direct capacitance measurements at high frequency.

TABLE I. Computed dielectric tensors for $BaZrS_3$ (bold font) and $Ba_3Zr_2S_7$ (italic).

$\overline{arepsilon_{ij}}$	$arepsilon^{ m ion}$	$arepsilon^{ m elec}$	$\bar{\varepsilon} = \frac{\varepsilon_{11} + \varepsilon_{22} + \varepsilon_{33}}{3}$
11	68.6 , 44.5	10.3 , 9.0	
22	55.6 , 44.5	10.6 , 9.0	76.2 , 43.0
33	73.5 , 14.6	10.6 , 7.5	

Our experimental measurements of ε_r are subject to a number of uncertainties. Calculating ε_r from the measured capacitance relies on accurate measurements of the sample dimensions. Our μ CT measurements are subject to a spatial resolution limit of 5 μ m, which results in an uncertainty of $\approx 2\%$ in $\varepsilon_{r,0}$. The statistical uncertainty in the best-fit parameters in the Nyquist analysis is $\approx 1\%$ and the statistical uncertainty in the high-frequency impedance measurements is lower still. We conclude that the spread in the dielectric constant comes from sample irregularities, including wiring and crystal quality, instead of measurement error. Ba₃Zr₂S₇ crystals produced by our salt-flux method have a minority Ba₄Zr₃S₁₀ phase intermixed, with the basal planes of the majority and minority phases aligned; it is unknown how this might affect our results. The Ag epoxy contacts often overhang the crystal, which can lead to a systematic error because the acrylic epoxy becomes part of the measured capacitor. However, the dielectric constant of this epoxy is small (less than 5) [15]. Therefore, the sample dominates the capacitance. All measured samples are highly resistive (we estimate resistivity $\rho > 10 \text{ M}\Omega$ for all samples), so interface effects are likely negligible. We can rule out systematic errors due to porosity in the Ag epoxy contacts, because measurement made with sputtered gold contacts give quantitatively consistent results.

To understand the atomic origins of the dielectric response, we computed the static dielectric tensor for BaZrS3 and Ba₃Zr₂S₇ using DFT (Table I). Our calculated average dielectric constant for BaZrS₃ is $\bar{\varepsilon} = 76.2$, including ionic and electronic contributions, and is in excellent agreement with the experimentally measured value of 80 ± 14 . We note that the dielectric response of BaZrS₃ was previously computed at the DFT local-density approximation (LDA) level to be 46 [7]. Our analysis indicates that the discrepancy between calculated values is due to lower vibrational mode frequencies in our calculations [7]. Our calculated average dielectric constant for Ba₃Zr₂S₇ is $\bar{\varepsilon} = 43.0$, which is within the uncertainty of the measured value of 72 ± 37 and substantially smaller than for perovskite. The experimentally measured values are nearly constant with frequency (1 kHz to 1 MHz) and temperature (2–300 K), meaning that a comparison with zero-temperature DFT results is meaningful. The electronic contribution to the dielectric response ε^{elec} is similar for BaZrS₃ and Ba₃Zr₂S₇, although slightly larger for perovskite. This is consistent with our understanding that the electronic structures of the two phases are similar, consisting of filled sulfide 3p states at the valence band edge and unoccupied Zr 4d states at the conduction band edge [5]. This leads to similar changes in orbital hybridization (and covalency) under applied electric fields. Therefore, the differences in total dielectric response originate from the difference in the ionic response by the phonons in the two materials.

The contribution of each optically active phonon mode μ to the total ionic dielectric response, here averaged over the principal axes, is given as

$$\varepsilon^{\text{ion}} = \sum_{\mu} \left(\frac{1}{3} \sum_{\alpha} \frac{1}{4\pi^2 \varepsilon_0 V} \frac{(Z_{\mu\alpha}^*)^2}{\nu_{\mu}^2} \right), \tag{1}$$

where $Z_{\mu\alpha}^*$ are the effective charges for mode μ , obtained as a mass-normalized sum of the atomic Born effective charges tensors (available in Tables S2 and S3 in the Supplemental Material [16]) for each infrared (IR-active) eigenvector [7]. The frequency squared of each IR mode v_{μ}^2 appears in the denominator of the summation in Eq. (1). These individual mode contributions add together linearly to obtain $\varepsilon^{\rm ion}$; therefore, a large ionic contribution can be due to large mode-effective charges, low-frequency IR-active phonons, or an increase in number of modes owing to the complexity of the asymmetric unit in the unit cell.

The perovskite BaZrS₃ possesses 57 optical modes, of which 25 $(\Gamma_{IR} = 9B_{1u} + 7B_{2u} + 9B_{3u})$ are IR active. Ba₃Zr₂S₇ possesses 141 optical modes, of which 50 are IR active $(\Gamma_{IR} = 10A_{2u} + 20E_u)$. Thus, the difference in connectivity of the octahedral layers between the two structures activates more oscillators in the RP phase; however, these IR modes can contribute in different ways to ε^{ion} . Furthermore, although the atomic Born effective charges for these two sulfides are similar, the displacement patterns (and hence relative motion of ions) can be significantly different owing to octahedral-connectivity disruption. The origin of the reduced ionic dielectric response in Ba₃Zr₂S₇ then is due to either stiffer vibrational modes or smaller mode-effective charges. Our analysis of the low-frequency phonon densities of states of the two phases indicates that the difference in the vibrational frequencies between the two phases are minor for the in-plane directions (Fig. S1 in [16]), but are more pronounced in the out-of-plane directions, due to a stiffening of the lattice and higher phonon frequencies along the [001] direction of $Ba_3Zr_2S_7$.

Figure 4 compares the relative contribution of each IR mode to the ionic dielectric response along each principal axis. For ε_{11} we find that BaZrS₃ exhibits two dominant IR modes, contributing at $63.8 \,\mathrm{cm}^{-1}$ (B_{1u} symmetry) and $112.5 \,\mathrm{cm}^{-1}$ (B_{1u}), and $Ba_3 Zr_2 S_7$ also has two dominant modes at similar frequencies (73.0 and $102.2 \,\mathrm{cm}^{-1}$, both of E_u symmetry); we also find that the mode-effective charges are similar for these four modes. The BaZrS $_3$ mode at $\nu =$ 63.8 cm⁻¹ is the lowest frequency among these four and makes the largest contribution to the ionic response. It consists predominately of Ba, Zr, and apical S displacements along the x direction, whereas the BaZrS₃ mode at $\nu = 112.5 \,\mathrm{cm}^{-1}$ includes motions of axial and equatorial S and Ba along the x direction. The RP mode at $73.0 \,\mathrm{cm}^{-1}$ (E_u) has Zr, equatorial S, interfacial Ba, and slight axial S displacements along the x direction. The RP mode at $102.2 \,\mathrm{cm}^{-1}$ (E_u) has motion of Ba, equatorial S, and axial S along the x direction (see the Supplemental Material for videos of the vibrational modes). We attribute the lower frequency of the dominant vibrational mode in the perovskite phase, compared to the

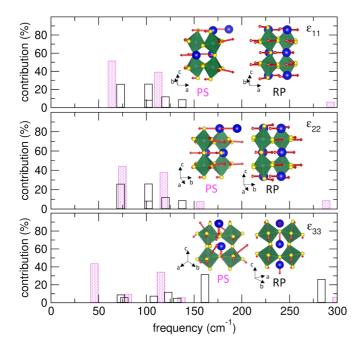


FIG. 4. Phonon mode contributions to the ionic part of the low-frequency dielectric tensor for BaZrS₃ (pink) and Ba₃Zr₂S₇ (black). The abscissa indicates the phonon frequencies; modes that contribute less than 5% of the total dielectric response are omitted for clarity. The insets show atomic motions for the dominant mode in each direction for each material: for ε_{11} , 63.8 cm⁻¹ for PS and 102.2 cm⁻¹ for RP; for ε_{22} , 74.8 cm⁻¹ for PS and 102.2 cm⁻¹ for RP; for ε_{33} , 45.6 cm⁻¹ for PS and 161.3 cm⁻¹ for RP. Atomic displacements are indicated with arrows; PS and RP denote perovskite and Ruddlesden-Popper, respectively.

RP phase, to the shorter Zr-S bond distances for the apical sites in $Ba_3Zr_2S_7$, leading to mode stiffening. Interestingly, although the perovskite phase is denser than the RP phase $(24.6\,\text{Å}^3/\text{atom}\ \text{vs}\ 26.3\,\text{Å}^3/\text{atom}$, respectively, at the DFT level), its vibrational modes are softer. We reconcile this discrepancy by comparing the RP bilayer volume-per-ZrS6 octahedron to the perovskite, to eliminate contributions from the BaS rocksalt layer from the analysis. With the rocksalt layers omitted, we find that the RP bilayer has a volume of $228.0\,\text{Å}^3$ per octahedron, compared to $245.8\,\text{Å}^3$ per octahedron for the perovskite, thereby justifying the softer phonon modes in the perovskite. This comparison is justified because the active in-plane phonons in $Ba_3Zr_2S_7$ derive from motions within the octahedral bilayer (see [16]).

The response and explanation for ε_{22} is similar to that for ε_{11} . In the case of ε_{22} the dominant modes for the perovskite and the RP phase are closer in frequency than for ε_{11} and again have comparable mode-effective charges. Therefore, the difference between ε_{22} for the two phases is smaller than for ε_{11} . The second-most dominant perovskite mode at $118.3 \, \mathrm{cm}^{-1} (B_{3u})$ is higher in frequency than the second-most dominant RP mode ($102.2 \, \mathrm{cm}^{-1}$, E_u symmetry). Similar to the behavior along the x direction, the $74.8 \, \mathrm{cm}^{-1} (B_{3u})$ perovskite mode has motion of Zr, apical S, and Ba along the y direction, while the $118.3 \, \mathrm{cm}^{-1}$ mode has motion of all S atoms and Ba along the y direction. The $73.0 \, \mathrm{cm}^{-1} (E_u)$ RP mode has motion of Zr, equatorial and axial S, and interfacial Ba along

the y direction, while the $102.2 \,\mathrm{cm}^{-1}$ (E_u) mode has motion of Ba and equatorial and axial S in the y direction.

The out-of-plane response ε_{33} shows the largest contrast between the two phases, as expected due to the broken octahedral corner connectivity along the long axis of Ba₃Zr₂S₇. We find two dominant modes for each phase, and the dominant perovskite mode at 45.6 cm⁻¹ (B_{2u}) occurs at lower frequency than the dominant RP mode at 161.3 cm⁻¹ (A_{2u}). This perovskite mode at 45.6 cm⁻¹ involves motions of all atoms along the z direction. The RP mode at 161.3 cm⁻¹ also involves all atoms moving along the z direction, with the interfacial Ba and S atoms exhibiting larger displacements than the atoms in the bilayer. There are several additional modes in the range 60–150 cm⁻¹ that contribute to ε_{33} in the RP phase.

The different ε_{33} response between the two phases can be further understood by analyzing the mode-effective charges (MECs). The dominant low-frequency mode in the perovskite $(45.6 \,\mathrm{cm}^{-1}, \,B_{2u})$ has a MEC that is approximately 100% larger than the low-frequency modes in the RP phase, which make relatively little contribution to the ionic response: -0.815 e for the perovskite mode at $45.6 \,\mathrm{cm}^{-1}$ (B_{2u}) vs -0.418 and -0.357 e for the RP modes at $73.2 \,\mathrm{cm}^{-1}$ (A_{2u}) and $76.9 \,\mathrm{cm}^{-1}$ (A_{2u}), respectively. The second-most dominant mode in the perovskite, at $115.3 \,\mathrm{cm}^{-1}$ (B_{2u}), has a MEC of -1.82 e. For the RP phase, the dominant mode at $161.3 \,\mathrm{cm}^{-1}$ (A_{2u}) has a MEC of $-1.75 \,e$ and the secondmost dominant mode at $283.4 \,\mathrm{cm}^{-1}$ (A_{2u}) has a MEC of -2.79 e. The contribution of these large MEC values to the ionic response is curtailed by the higher mode frequencies [cf. the v_{μ}^2 term in the denominator of Eq. (1)], with the net effect that the out-of-plane ionic response of Ba₃Zr₂S₇ is substantially suppressed.

BaZrS₃ and Ba₃Zr₂S₇ have among the strongest lowfrequency dielectric responses reported for semiconductors with a band gap in the VIS-NIR. In Fig. 5 we summarize our results by presenting our measured values on an Ashby plot of low-frequency dielectric constant $\varepsilon_{r,0}$ vs E_g and including a number of well-known semiconductor materials. Materials based on light elements and a motif of tetrahedral covalent bonding, including many group-IV, III-V, and II-VI semiconductors, have $\varepsilon_{r,0} \approx 10$. A stronger low-frequency dielectric response is associated with more complex crystal structures, such as complex oxides with a band gap in the ultraviolet, and lead salts with a band gap in the mid-IR. Among semiconductors with a band gap in the VIS-NIR, the strongest dielectric response is found among materials with complex crystal structures and mixed bonding motifs, such as layered SnS, halide perovskites, and the complex chalcogenides reported here.

The large low-frequency dielectric response suggests that polaron effects may be prominent in the charge transport properties and optical spectra of these and related complex chalcogenide semiconductors. The Fröhlich coupling constant α parametrizes the interaction between charge carriers and polar phonons, and the tendency toward polaron formation. We estimate $\alpha\approx 0.8-2$ for BaZrS $_3$ and $\alpha\approx 1$ for Ba $_3$ Zr $_2$ S $_7$, using available data for phonon frequency and electron effective mass [4,18,19]. These are comparable to the range reported for lead halide perovskites (1.5–2.7) and implies that charge carriers may be large polarons [20,21].

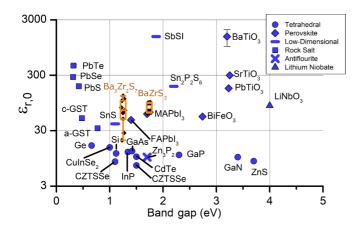


FIG. 5. Ashby plot of the low-frequency relative dielectric constant $\varepsilon_{r,0}$ vs band gap, showing our results for BaZrS₃ and Ba₃Zr₂S₇ together with results for a number of well-known semiconductor materials, grouped by crystal structure type as indicated by the symbols. The results for BaZrS₃ and Ba₃Zr₂S₇ are presented as orange box-and-whisker symbols and black points, which include measurements on multiple samples and using multiple techniques: seven unique samples and eleven independent measurements for BaZrS₃ and five unique samples and nine independent measurements for Ba₃Zr₂S₇. Data for all but the lead salts are as presented in Ref. [17].

In conclusion, we find that complex chalcogenides in the Ba-Zr-S system in perovskite and Ruddlesden-Popper structures are highly polarizable semiconductors, with lowfrequency dielectric constant comparable to or even exceeding the highest reported values for semiconductors with a band gap in the NIR-VIS, including halide perovskites. We showed that the anisotropy in the dielectric response is sensitive to the three-dimensional connectivity of the transition metal-sulfide octahedra, which manifest in changes in IR mode-effective charges and frequencies. This family of complex chalcogenide semiconductors therefore combines strong optical absorption, excellent environmental stability, and strong dielectric response and consists of abundant and nontoxic elements [3,4,19]. It is an interesting and open question whether the strong dielectric polarizability reported here is related to the long radiative lifetime reported previously in Ba₃Zr₂S₇, as suggested for halide perovskites [2,22–25].

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^[1] R. Jaramillo and J. Ravichandran, APL Mater. 7, 100902 (2019).

^[2] S. Niu, D. Sarkar, K. Williams, Y. Zhou, Y. Li, E. Bianco, H. Huyan, S. B. Cronin, M. E. McConney, R. Haiges, R. Jaramillo, D. J. Singh, W. A. Tisdale, R. Kapadia, and J. Ravichandran, Chem. Mater. 30, 4882 (2018).

^[3] S. Niu, H. Huyan, Y. Liu, M. Yeung, K. Ye, L. Blankemeier, T. Orvis, D. Sarkar, D. J. Singh, R. Kapadia, and J. Ravichandran, Adv. Mater. 29, 1604733 (2017).

^[4] Y. Nishigaki, T. Nagai, M. Nishiwaki, T. Aizawa, M. Kozawa, K. Hanzawa, Y. Kato, H. Sai, H. Hiramatsu, H. Hosono, and H. Fujiwara, Sol. RRL 4, 1900555 (2020).

^[5] W. Li, S. Niu, B. Zhao, R. Haiges, Z. Zhang, J. Ravichandran, and A. Janotti, Phys. Rev. Mater. 3, 101601 (2019).

^[6] Y. Zhang, T. Shimada, T. Kitamura, and J. Wang, J. Phys. Chem. Lett. 8, 5834 (2017).

^[7] J. W. Bennett, I. Grinberg, and A. M. Rappe, Phys. Rev. B 79, 235115 (2009).

^[8] S. Niu, B. Zhao, K. Ye, E. Bianco, J. Zhou, M. E. McConney, C. Settens, R. Haiges, R. Jaramillo, and J. Ravichandran, J. Mater. Res. 34, 3819 (2019).

^[9] G. Kresse and J. Furthmüller, Phys. Rev. B 54, 11169 (1996).

^[10] G. Kresse and D. Joubert, Phys. Rev. B 59, 1758 (1999).

^[11] J. P. Perdew, A. Ruzsinszky, G. I. Csonka, O. A. Vydrov, G. E. Scuseria, L. A. Constantin, X. Zhou, and K. Burke, Phys. Rev. Lett. 100, 136406 (2008).

^[12] J. Hemberger, P. Lunkenheimer, R. Viana, R. Böhmer, and A. Loidl, Phys. Rev. B 52, 13159 (1995).

^[13] T. F. Nova, A. S. Disa, M. Fechner, and A. Cavalleri, Science 364, 1075 (2019).

^[14] X. Li, T. Qiu, J. Zhang, E. Baldini, J. Lu, A. M. Rappe, and K. A. Nelson, Science 364, 1079 (2019).

^[15] J. Sheng, H. Chen, B. Li, and L. Chang, Appl. Phys. A 110, 511 (2013).

^[16] See Supplemental Material at http://link.aps.org/supplemental/ 10.1103/PhysRevMaterials.4.091601 for a list of samples studied, the phonon density of states, Born effective charge tensors, videos of phonon modes, and impedance spectroscopy fit parameters.

^[17] K. F. Young and H. P. R. Frederikse, J. Phys. Chem. Ref. Data 2, 313 (1973).

^[18] N. Gross, Y.-Y. Sun, S. Perera, H. Hui, X. Wei, S. Zhang, H. Zeng, and B. A. Weinstein, Phys. Rev. Appl. 8, 044014 (2017).

- [19] S. Niu, J. Milam-Guerrero, Y. Zhou, K. Ye, B. Zhao, B. C. Melot, and J. Ravichandran, J. Mater. Res. 33, 4135 (2018).
- [20] K. Miyata, D. Meggiolaro, M. T. Trinh, P. P. Joshi, E. Mosconi, S. C. Jones, F. D. Angelis, and X.-Y. Zhu, Sci. Adv. 3, e1701217 (2017).
- [21] M. Sendner, P. K. Nayak, D. A. Egger, S. Beck, C. Müller, B. Epding, W. Kowalsky, L. Kronik, H. J. Snaith, A. Pucci, and R. Lovrinčić, Mater. Horiz. 3, 613 (2016).
- [22] O. Yaffe, Y. Guo, L. Z. Tan, D. A. Egger, T. Hull, C. C. Stoumpos, F. Zheng, T. F. Heinz, L. Kronik, M. G. Kanatzidis,

- J. S. Owen, A. M. Rappe, M. A. Pimenta, and L. E. Brus, Phys. Rev. Lett. **118**, 136001 (2017).
- [23] D. A. Egger, A. Bera, D. Cahen, G. Hodes, T. Kirchartz, L. Kronik, R. Lovrincic, A. M. Rappe, D. R. Reichman, and O. Yaffe, Adv. Mater. 30, 1800691 (2018).
- [24] I. Anusca, S. Balčiūnas, P. Gemeiner, Š. Svirskas, M. Sanlialp, G. Lackner, C. Fettkenhauer, J. Belovickis, V. Samulionis, M. Ivanov, B. Dkhil, J. Banys, V. V. Shvartsman, and D. C. Lupascu, Adv. Energy Mater. 7, 1700600 (2017).
- [25] H. Zhu, K. Miyata, Y. Fu, J. Wang, P. P. Joshi, D. Niesner, K. W. Williams, S. Jin, and X.-Y. Zhu, Science 353, 1409 (2016).